

4-bit dual supply level translator without direction control pin

Datasheet – production data

Features

- 45 MHz: 90 Mbps (max.) data rate at $V_L = 1.8\text{ V}$, $V_{CC} = 3.3\text{ V}$
- Bi-directional level translation without direction control pin
- Wide voltage range ($V_L \leq V_{CC}$):
 - V_L ranges from 1.65 to 3.6 V
 - V_{CC} ranges from 1.65 to 5.5 V
- Totem-pole driving
- 5.5 V tolerant enable pin
- ESD performance on all pins: $\pm 2\text{ kV HBM}$
- Small package and footprint
QFN12 (1.7 x 2.0 mm)

Applications

- Low-voltage system level translation
- Mobile phones and other mobile devices

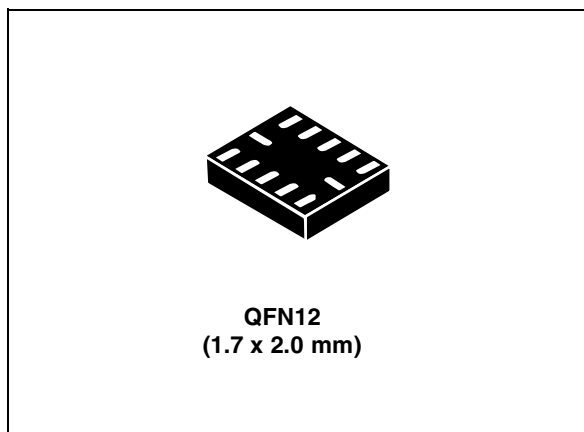


Table 1. Device summary

| Order code | Package | Packing | Package topmark |
|------------|-------------------------|-------------------------------------|-----------------|
| ST2149BQTR | QFN12 (1.7 x 2.0 mm) | Tape and reel (3000 parts per reel) | 49A |

Contents

| | | |
|----------|---|-----------|
| 1 | Description | 5 |
| 2 | Pin settings | 6 |
| | 2.1 Pin connection | 6 |
| | 2.2 Pin description | 6 |
| 3 | Logic diagram | 7 |
| | Device block diagrams | 7 |
| 4 | Supplementary notes | 9 |
| | 4.1 Driver requirement | 9 |
| | 4.2 Load driving capability | 9 |
| | 4.3 Truth table | 9 |
| 5 | Maximum ratings | 10 |
| | Recommended operating conditions | 10 |
| 6 | Electrical characteristics | 11 |
| | AC characteristics | 13 |
| 7 | Test circuit | 16 |
| 8 | Package mechanical data | 18 |
| 9 | Revision history | 22 |

List of tables

| | | |
|-----------|---|----|
| Table 1. | Device summary | 1 |
| Table 2. | Pin description | 6 |
| Table 3. | Truth table. | 9 |
| Table 4. | Absolute maximum ratings | 10 |
| Table 5. | Recommended operating conditions | 10 |
| Table 6. | DC characteristics | 11 |
| Table 7. | AC characteristics - test conditions: $V_L = 1.65 - 1.95 \text{ V}$ | 13 |
| Table 8. | AC characteristics - test conditions: $V_L = 2.3 - 2.7 \text{ V}$ | 14 |
| Table 9. | AC characteristics - test conditions: $V_L = 3.0 - 3.6 \text{ V}$ | 15 |
| Table 10. | Test circuit switches | 16 |
| Table 11. | Waveform symbol value | 16 |
| Table 12. | Mechanical data for QFN12 (1.7 x 2.0 mm) - 0.40 mm pitch | 19 |
| Table 13. | Carrier tape dimensions | 20 |
| Table 14. | Reel dimensions | 21 |
| Table 15. | Document revision history | 22 |

List of figures

| | | |
|------------|---|----|
| Figure 1. | Pin connection (top through view) | 6 |
| Figure 2. | Logic block diagram | 7 |
| Figure 3. | ST2149BQTR block diagram | 7 |
| Figure 4. | Application block diagram | 8 |
| Figure 5. | Test circuit | 16 |
| Figure 6. | Waveform - propagation delay (f = 1 MHz, 50% duty cycle). | 17 |
| Figure 7. | Waveform - output enable and disable time (f = 1 MHz, 50% duty cycle) | 17 |
| Figure 8. | Package outline for QFN12 (1.7 x 2.0 mm) - 0.40 mm pitch. | 18 |
| Figure 9. | Carrier tape for QFN12 (1.7 x 2.0 mm) - 0.40 mm pitch | 20 |
| Figure 10. | Reel information for QFN12 (1.7 x 2.0 mm) - 0.40 mm pitch | 21 |

1 Description

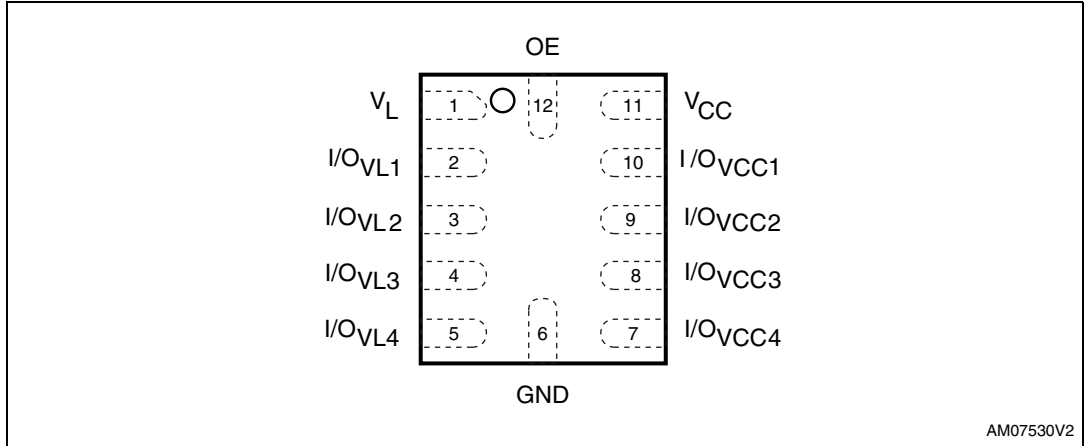
The ST2149B is a 4-bit dual supply level translator which provides the level shifting capability to allow data transfer in a multi-voltage system. Externally applied voltages, V_{CC} and V_L , set the logic levels on either side of the device. Its architecture allows bi-directional level translation without a control pin.

The ST2149B accepts V_L from 1.65 to 3.6 V and V_{CC} from V_L to 5.5 V, making it ideal for data transfer between low-voltage ASICs/PLD and higher voltage systems. This device has a tri-state output mode which can be used to disable all I/Os.

2 Pin settings

2.1 Pin connection

Figure 1. Pin connection (top through view)



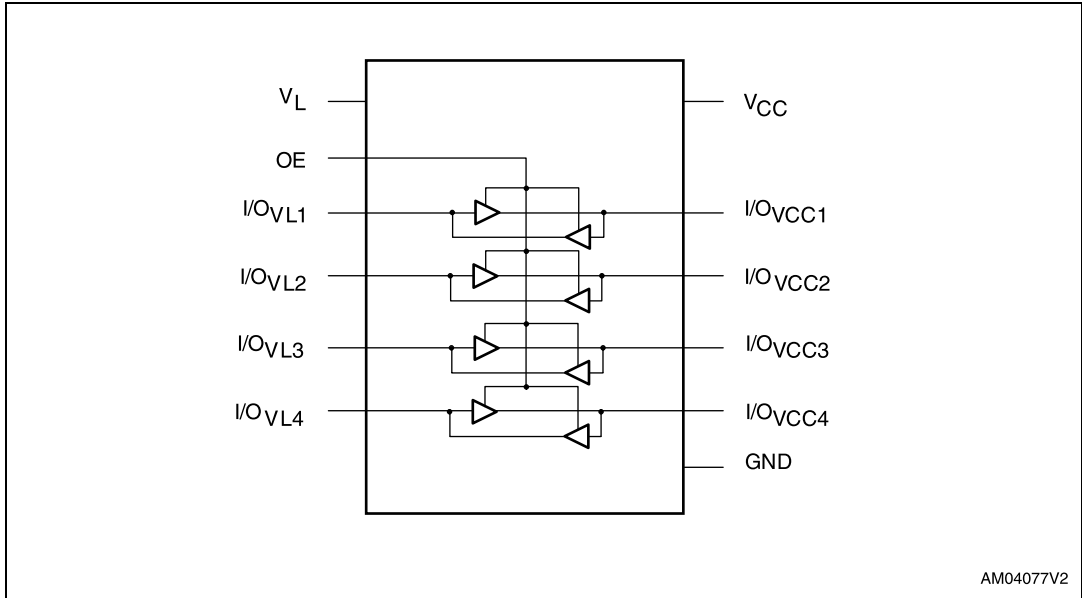
2.2 Pin description

Table 2. Pin description

| Pin number | Symbol | Name and function |
|------------|--------------|-------------------|
| 1 | V_L | Supply voltage |
| 2 | I/O_{VL1} | Data input/output |
| 3 | I/O_{VL2} | Data input/output |
| 4 | I/O_{VL3} | Data input/output |
| 5 | I/O_{VL4} | Data input/output |
| 6 | GND | Ground |
| 7 | I/O_{VCC4} | Data input/output |
| 8 | I/O_{VCC3} | Data input/output |
| 9 | I/O_{VCC2} | Data input/output |
| 10 | I/O_{VCC1} | Data input/output |
| 11 | V_{CC} | Supply voltage |
| 12 | OE | Output enable |

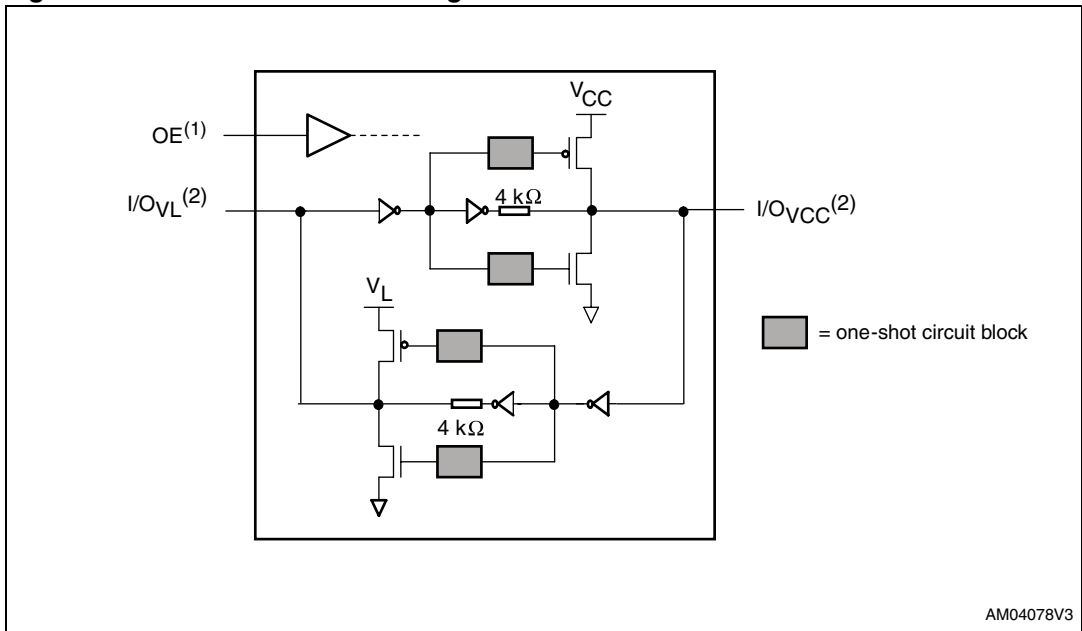
3 Logic diagram

Figure 2. Logic block diagram



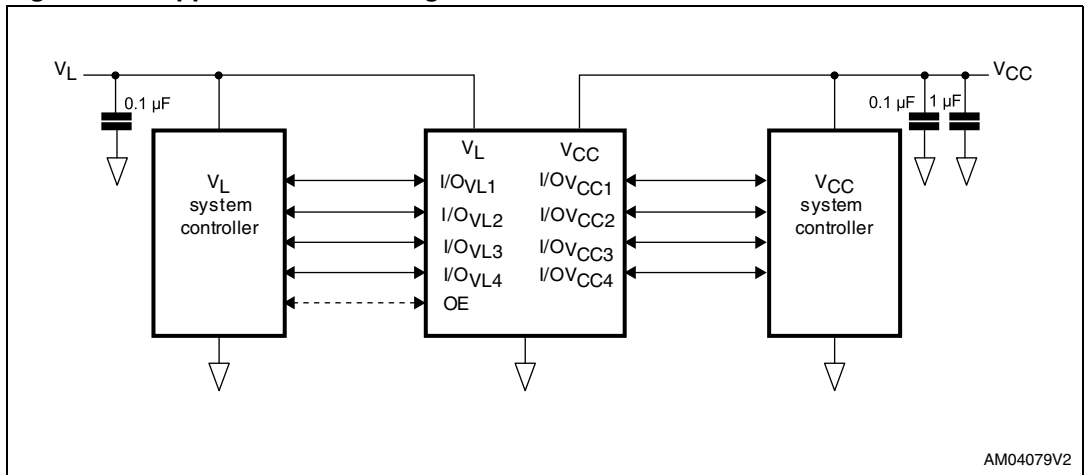
Device block diagrams

Figure 3. ST2149BQTR block diagram



1. When OE is LOW, all I/Os are in high-impedance mode.
2. ST2149BQTR has 4 channels. For simplicity, the above diagram shows only 1 channel.

Figure 4. Application block diagram



4 Supplementary notes

4.1 Driver requirement

For proper operation, the driver from each side of the device must be able to source and sink a minimum of 1 mA current. The device architecture requires the driver to source/sink maximum current of ($V_{CC}/4$) mA to/from the weak 4 k Ω output buffer.

4.2 Load driving capability

To support the architecture that allows level translation without the direction pin, the one-shot transistor is turned ON only during state transition at the output side. After the one-shot transistor is turned OFF, only the 4 k Ω resistor maintains the output logic state. So, a resistive load or pull-up resistor less than 50 k Ω is not recommended for proper operation.

4.3 Truth table

Table 3. Truth table

| Enable | Bi-directional input/output | |
|------------------|-----------------------------|------------------|
| | I/O_{VCC} | I/O_{VL} |
| H ⁽¹⁾ | H ⁽²⁾ | H ⁽¹⁾ |
| H ⁽¹⁾ | L | L |
| L | Z ⁽³⁾ | Z ⁽³⁾ |

1. High level V_L power supply referred.
2. High level V_{CC} power supply referred.
3. Z = high impedance.

5 Maximum ratings

Stressing the device above the ratings listed in [Table 4](#) may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in [Recommended operating conditions](#) of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 4. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|--------------|--|------------------------|------|
| V_L | Supply voltage | -0.3 to 4.6 | V |
| V_{CC} | Supply voltage | -0.3 to 6.5 | V |
| V_{OE} | DC control input voltage | -0.3 to 6.5 | V |
| $V_{I/OVL}$ | DC I/O _{VL} input voltage (OE = GND or V_L) | -0.3 to $V_L + 0.3$ | V |
| $V_{I/OVCC}$ | DC I/O _{VCC} input voltage (OE = GND or V_L) | -0.3 to $V_{CC} + 0.3$ | V |
| I_{IK} | DC input diode current | -20 | mA |
| $I_{I/OVL}$ | DC output current | ±25 | mA |
| $I_{I/OVCC}$ | DC output current | ±25 | mA |
| I_{SCOUT} | Short-circuit duration, continuous | 40 | mA |
| P_D | Power dissipation | 500 | mW |
| T_{STG} | Storage temperature | -65 to 150 | °C |
| T_L | Lead temperature (10 seconds) | 300 | °C |
| ESD | Electrostatic discharge protection (HBM) | ±2 | kV |

Recommended operating conditions

Table 5. Recommended operating conditions

| Symbol | Parameter | Min. | Typ. | Max. | Unit |
|--------------|---|-------|------|----------|------|
| V_L | Supply voltage | 1.65 | – | 3.6 | V |
| V_{CC} | Supply voltage | V_L | – | 5.5 | V |
| V_{OE} | Input voltage (OE output enable pin, V_L power supply referred) | 0 | – | 3.6 | V |
| $V_{I/OVL}$ | I/O _{VL} voltage | 0 | – | V_L | V |
| $V_{I/OVCC}$ | I/O _{VCC} voltage | 0 | – | V_{CC} | V |
| T_{OP} | Operating temperature | -40 | – | 85 | °C |
| dt/dV | Input rise and fall time | 0 | – | 1 | ns/V |

6 Electrical characteristics

Over recommended operating conditions unless otherwise noted. All typical values are at $T_A = 25\text{ }^\circ\text{C}$.

Table 6. DC characteristics

| Symbol | Parameter | V_L | V_{CC} | Test conditions | Value | | | | | Unit |
|-------------|---|-------------|--------------|--------------------------------|----------------------------------|------|--------------|----------------------------|--------------|---------------|
| | | | | | $T_A = 25\text{ }^\circ\text{C}$ | | | -40 to 85 $^\circ\text{C}$ | | |
| | | | | | Min. | Typ. | Max. | Min. | Max. | |
| V_{IHL} | High-level input voltage (I/O V_L) | 1.65 to 3.6 | V_L to 5.5 | | 0.8 V_L | – | – | 0.8 V_L | – | V |
| V_{ILL} | Low-level input voltage (I/O V_L) | 1.65 to 3.6 | V_L to 5.5 | | – | – | 0.2 V_L | – | 0.2 V_L | V |
| V_{IHC} | High-level input voltage (I/O V_{CC}) | 1.65 to 3.6 | V_L to 5.5 | | 0.8 V_{CC} | – | – | 0.8 V_{CC} | – | V |
| V_{ILC} | Low-level input voltage (I/O V_{CC}) | 1.65 to 3.6 | V_L to 5.5 | | – | – | 0.2 V_{CC} | – | 0.2 V_{CC} | V |
| V_{IH-OE} | High-level input voltage (OE) | 1.65 to 3.6 | V_L to 5.5 | | 0.8 V_L | – | – | 0.8 V_L | – | V |
| V_{IL-OE} | Low-level input voltage (OE) | 1.65 to 3.6 | V_L to 5.5 | | – | – | 0.2 V_L | – | 0.2 V_L | V |
| V_{OHL} | High-level output voltage (I/O V_L) | 1.65 to 3.6 | V_L to 5.5 | $I_O = -60\text{ }\mu\text{A}$ | $V_L - 0.4$ | – | – | $V_L - 0.4$ | – | V |
| V_{OLL} | Low-level output voltage (I/O V_L) | 1.65 to 3.6 | V_L to 5.5 | $I_O = +60\text{ }\mu\text{A}$ | – | – | 0.4 | – | 0.4 | V |
| V_{OHC} | High-level output voltage (I/O V_{CC}) | 1.65 to 3.6 | V_L to 5.5 | $I_O = -60\text{ }\mu\text{A}$ | $V_{CC} - 0.4$ | – | – | $V_{CC} - 0.4$ | – | V |
| V_{OLC} | Low-level output voltage (I/O V_{CC}) | 1.65 to 3.6 | V_L to 5.5 | $I_O = +60\text{ }\mu\text{A}$ | – | – | 0.4 | – | 0.4 | V |
| I_{OE} | Control input leakage current (OE) | 1.65 to 3.6 | V_L to 5.5 | $V_I = \text{GND or } V_L$ | – | – | 0.1 | – | 1 | μA |

Table 6. DC characteristics (continued)

| Symbol | Parameter | V _L | V _{CC} | Test conditions | Value | | | | | Unit |
|---------------------|--|----------------|-----------------------|--|------------------------|------|------|--------------|------|------|
| | | | | | T _A = 25 °C | | | -40 to 85 °C | | |
| | | | | | Min. | Typ. | Max. | Min. | Max. | |
| I _{IO_LKG} | High impedance leakage current (I/O _{VL} , I/O _{VCC}) | 1.65 to 3.6 | V _L to 5.5 | OE = GND I/O _{VL} = high I/O _{VCC} = low | – | – | 0.1 | – | 1 | μA |
| | | | | OE = GND I/O _{VL} = low I/O _{VCC} = high | – | – | 0.1 | – | 1 | μA |
| I _{QVCC} | Quiescent supply current V _{CC} | 1.65 to 3.6 | V _L to 5.5 | OE = V _L | -- | – | 7 | – | 9 | μA |
| I _{QVL} | Quiescent supply current V _L | 1.65 to 3.6 | V _L to 5.5 | OE = V _L | – | – | 0.1 | – | 1 | μA |
| I _{Z-VCC} | High impedance quiescent supply current V _{CC} | 1.65 to 3.6 | V _L to 5.5 | OE = GND I/O = Hi-Z | – | – | 0.1 | – | 1 | μA |
| I _{Z-VL} | High impedance quiescent supply current V _L | 1.65 to 3.6 | V _L to 5.5 | OE = GND I/O = Hi-Z | – | – | 0.1 | – | 1 | μA |

AC characteristics

Load $C_L = 15$ pF; driver $t_r = t_f \leq 6$ ns over temperature range -40 °C to 85 °C.

Table 7. AC characteristics - test conditions: $V_L = 1.65 - 1.95$ V

| Symbol | Parameter | $V_{CC} = V_L - 1.95$ V | | $V_{CC} = 2.3 - 2.7$ V | | $V_{CC} = 3.0 - 3.6$ V | | $V_{CC} = 4.5 - 5.5$ V | | Unit | |
|--------------------|---------------------------------|-------------------------|------|------------------------|------|------------------------|------|------------------------|------|------|----|
| | | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Max. | | |
| t_{RVCC} | Rise time I/O_{VCC} | - | 5.2 | - | 3.2 | - | 2.4 | - | 1.8 | ns | |
| t_{FVCC} | Fall time I/O_{VCC} | - | 3.2 | - | 1.5 | - | 1.3 | - | 1.2 | ns | |
| t_{RVL} | Rise time I/O_{VL} | - | 3.3 | - | 3.3 | - | 3.3 | - | 3.3 | ns | |
| t_{FVL} | Fall time I/O_{VL} | - | 1.5 | - | 1.4 | - | 1.4 | - | 1.3 | ns | |
| $t_{I/O_{VL-VCC}}$ | Propagation delay time | | | | | | | | | | |
| | I/O_{VL-LH} to I/O_{VCC-LH} | t_{PLH} | - | 7.6 | - | 5.8 | - | 5.0 | - | 4.4 | ns |
| | I/O_{VL-HL} to I/O_{VCC-HL} | t_{PHL} | - | 4.6 | - | 3.9 | - | 3.9 | - | 3.5 | ns |
| $t_{I/O_{VCC-VL}}$ | Propagation delay time | | | | | | | | | | |
| | I/O_{VCC-LH} to I/O_{VL-LH} | t_{PLH} | - | 7.1 | - | 6.6 | - | 4.8 | - | 4.6 | ns |
| | I/O_{VCC-HL} to I/O_{VL-HL} | t_{PHL} | - | 5.3 | - | 5.1 | - | 4.3 | - | 4.1 | ns |
| t_{PZL} | Output enable time t_{PZL} | - | 28 | - | 28 | - | 28 | - | 28 | ns | |
| t_{PZH} | Output enable time t_{PZH} | - | 90 | - | 90 | - | 90 | - | 90 | ns | |
| t_{PLZ} | Output disable time t_{PLZ} | | 120 | - | 120 | - | 120 | - | 120 | ns | |
| t_{PHZ} | Output disable time t_{PHZ} | | 80 | - | 60 | - | 50 | - | 50 | ns | |
| D_R | Data rate ⁽¹⁾ | 56 | - | 90 | - | 90 | - | 90 | - | Mbps | |

1. Data rate is guaranteed based on the condition that output I/O signal rise/fall time is less than 15% of period of input I/O signal; input I/O signal is at 50% duty cycle and output I/O signal duty cycle deviation is less than $50\% \pm 10\%$.

Table 8. AC characteristics - test conditions: $V_L = 2.3 - 2.7 V$

| Symbol | Parameter | | $V_{CC} = V_L - 2.7 V$ | | $V_{CC} = 3.0 - 3.6 V$ | | $V_{CC} = 4.5 - 5.5 V$ | | Unit | |
|-----------------|---------------------------------|--|------------------------|------|------------------------|------|------------------------|------|------|----|
| | | | Min. | Max. | Min. | Max. | Min. | Max. | | |
| t_{RVCC} | Rise time I/O_{VCC} | | - | 3.3 | - | 2.2 | - | 1.7 | ns | |
| t_{FVCC} | Fall time I/O_{VCC} | | - | 1.7 | - | 1.6 | - | 1.4 | ns | |
| t_{RVL} | Rise time I/O_{VL} | | - | 2.2 | - | 2.2 | - | 1.9 | ns | |
| t_{FVL} | Fall time I/O_{VL} | | - | 1.3 | - | 1.2 | - | 1.2 | ns | |
| $t_{I/OVL-VCC}$ | Propagation delay time | | | | | | | | | |
| | I/O_{VL-LH} to I/O_{VCC-LH} | | t_{PLH} | - | 4.8 | - | 4.3 | - | 3.9 | ns |
| | I/O_{VL-HL} to I/O_{VCC-HL} | | t_{PHL} | - | 3.7 | - | 3.3 | - | 2.9 | ns |
| $t_{I/OVCC-VL}$ | Propagation delay time | | | | | | | | | |
| | I/O_{VCC-LH} to I/O_{VL-LH} | | t_{PLH} | - | 3.9 | - | 3.5 | - | 3.5 | ns |
| | I/O_{VCC-HL} to I/O_{VL-HL} | | t_{PHL} | - | 3.6 | - | 3.5 | - | 3.4 | ns |
| t_{PZL} | Output enable time t_{PZL} | | - | 25 | - | 25 | - | 25 | ns | |
| t_{PZH} | Output enable time t_{PZH} | | - | 100 | - | 100 | - | 70 | ns | |
| t_{PLZ} | Output disable time t_{PLZ} | | - | 90 | - | 90 | - | 90 | ns | |
| t_{PHZ} | Output disable time t_{PHZ} | | - | 50 | - | 50 | - | 50 | ns | |
| D_R | Data rate ⁽¹⁾ | | 90 | - | 136 | - | 158 | - | Mbps | |

1. Data rate is guaranteed based on the condition that output I/O signal rise/fall time is less than 15% of period of input I/O signal; input I/O signal is at 50% duty cycle and output I/O signal duty cycle deviation is less than $50\% \pm 10\%$.

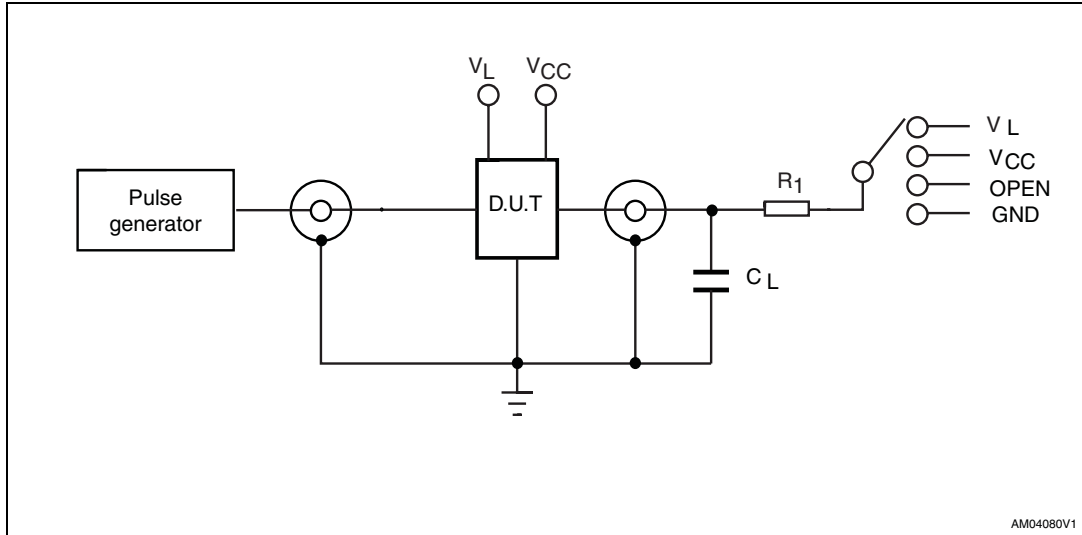
Table 9. AC characteristics - test conditions: $V_L = 3.0 - 3.6 V$

| Symbol | Parameter | | $V_{CC} = V_L - 3.6 V$ | | $V_{CC} = 4.5 - 5.5 V$ | | Unit | |
|--------------------|---------------------------------|--|------------------------|------|------------------------|------|------|----|
| | | | Min. | Max. | Min. | Max. | | |
| t_{RVCC} | Rise time I/O_{VCC} | | - | 2.1 | - | 1.7 | ns | |
| t_{FVCC} | Fall time I/O_{VCC} | | - | 1.3 | - | 1.3 | ns | |
| t_{RVL} | Rise time I/O_{VL} | | - | 1.6 | - | 1.5 | ns | |
| t_{FVL} | Fall time I/O_{VL} | | - | 1.1 | - | 1.1 | ns | |
| $t_{I/O_{VL-VCC}}$ | Propagation delay time | | | | | | | |
| | I/O_{VL-LH} to I/O_{VCC-LH} | | t_{PLH} | - | 4.1 | - | 4.1 | ns |
| | I/O_{VL-HL} to I/O_{VCC-HL} | | t_{PHL} | - | 2.9 | - | 2.6 | ns |
| $t_{I/O_{VCC-VL}}$ | Propagation delay time | | | | | | | |
| | I/O_{VCC-LH} to I/O_{VL-LH} | | t_{PLH} | - | 4.0 | - | 4.0 | ns |
| | I/O_{VCC-HL} to I/O_{VL-HL} | | t_{PHL} | - | 2.6 | - | 2.5 | ns |
| t_{PZL} | Output enable time t_{PZL} | | - | 15 | - | 15 | ns | |
| t_{PZH} | Output enable time t_{PZH} | | - | 70 | - | 15 | ns | |
| t_{PLZ} | Output disable time t_{PLZ} | | - | 70 | - | 70 | ns | |
| t_{PHZ} | Output disable time t_{PHZ} | | - | 50 | - | 50 | ns | |
| D_R | Data rate ⁽¹⁾ | | 144 | - | 186 | - | Mbps | |

1. Data rate is guaranteed based on the condition that output I/O signal rise/fall time is less than 15% of period of input I/O signal; input I/O signal is at 50% duty cycle and output I/O signal duty cycle deviation is less than $50\% \pm 10\%$.

7 Test circuit

Figure 5. Test circuit



AM04080V1

Table 10. Test circuit switches

| Test | C _L | R ₁ | Switch |
|-------------------------------------|----------------|----------------|-----------------------------------|
| t _{PLH} , t _{PHL} | 15 pF | 20 kΩ | Open |
| t _r , t _f | 15 pF | 20 kΩ | Open |
| t _{PZL} , t _{PLZ} | 15 pF | 20 kΩ | V _L or V _{CC} |
| t _{PZH} , t _{PHZ} | 15 pF | 20 kΩ | GND |

Table 11. Waveform symbol value

| Symbol | Driving I/O _{V_L} | | Driving I/O _{V_{CC}} | |
|-----------------|---|--|---|--|
| | 1.65 V ≤ V _L ≤ V _{CC} ≤ 2.5 V | 3.3 V ≤ V _L ≤ V _{CC} ≤ 5.5 V | 1.65 V ≤ V _L ≤ V _{CC} ≤ 2.5 V | 3.3 V ≤ V _L ≤ V _{CC} ≤ 5.5 V |
| V _{IH} | V _L | V _L | V _{CC} | V _{CC} |
| V _{IM} | 50% V _L | 50% V _L | 50% V _{CC} | 50% V _{CC} |
| V _{OM} | 50% V _{CC} | 50% V _{CC} | 50% V _L | 50% V _L |

Figure 6. Waveform - propagation delay (f = 1 MHz, 50% duty cycle)

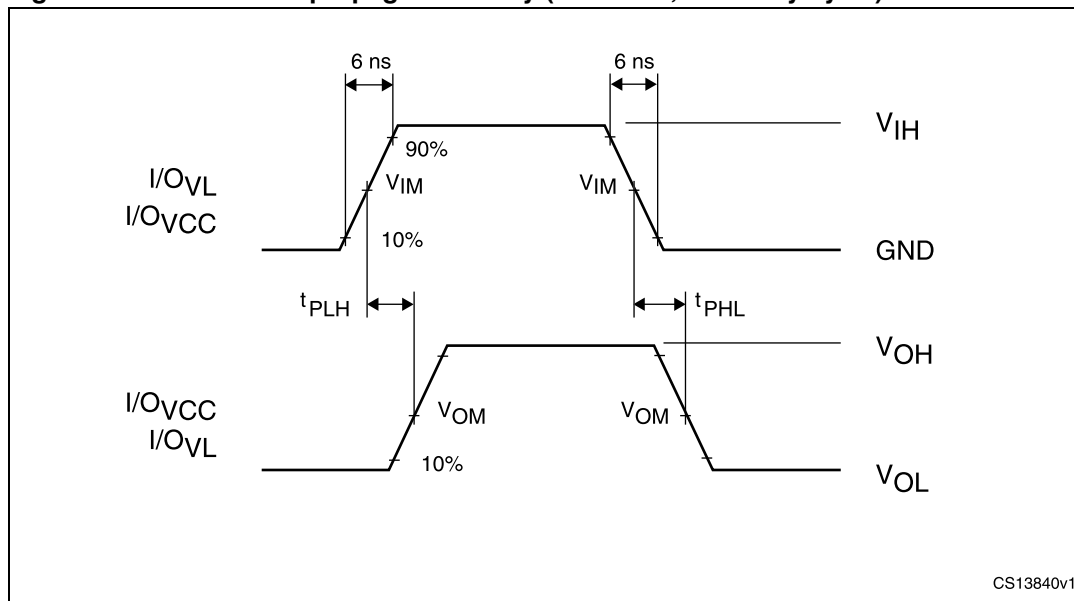
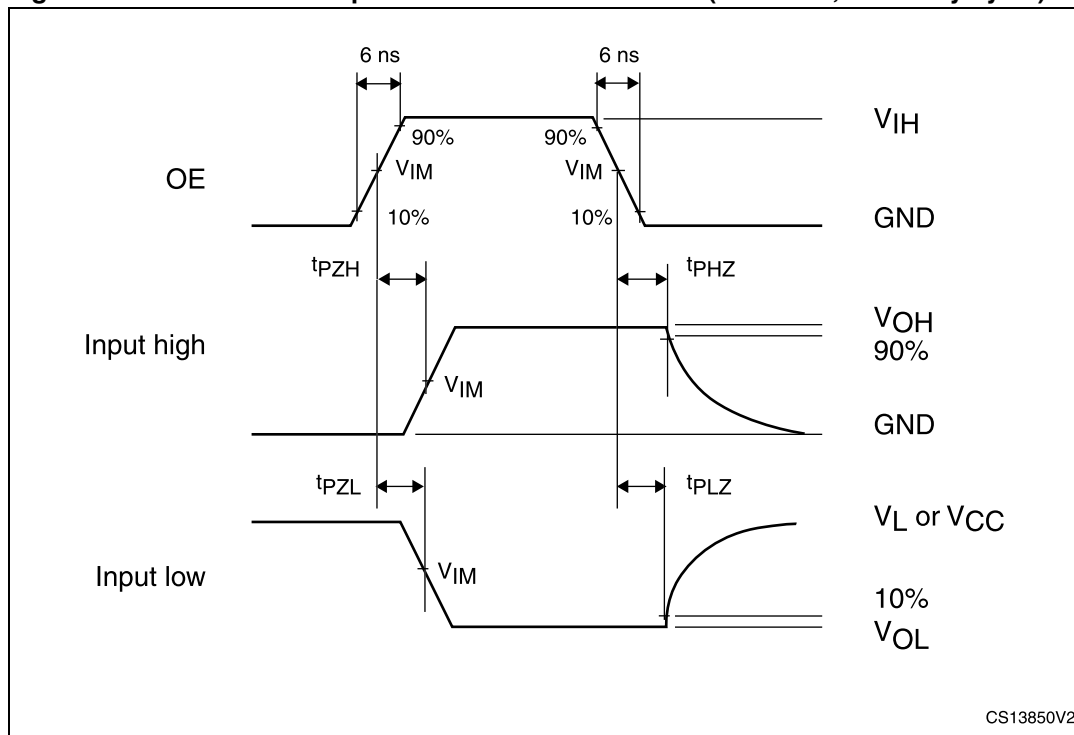


Figure 7. Waveform - output enable and disable time (f = 1 MHz, 50% duty cycle)



8 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Figure 8. Package outline for QFN12 (1.7 x 2.0 mm) - 0.40 mm pitch

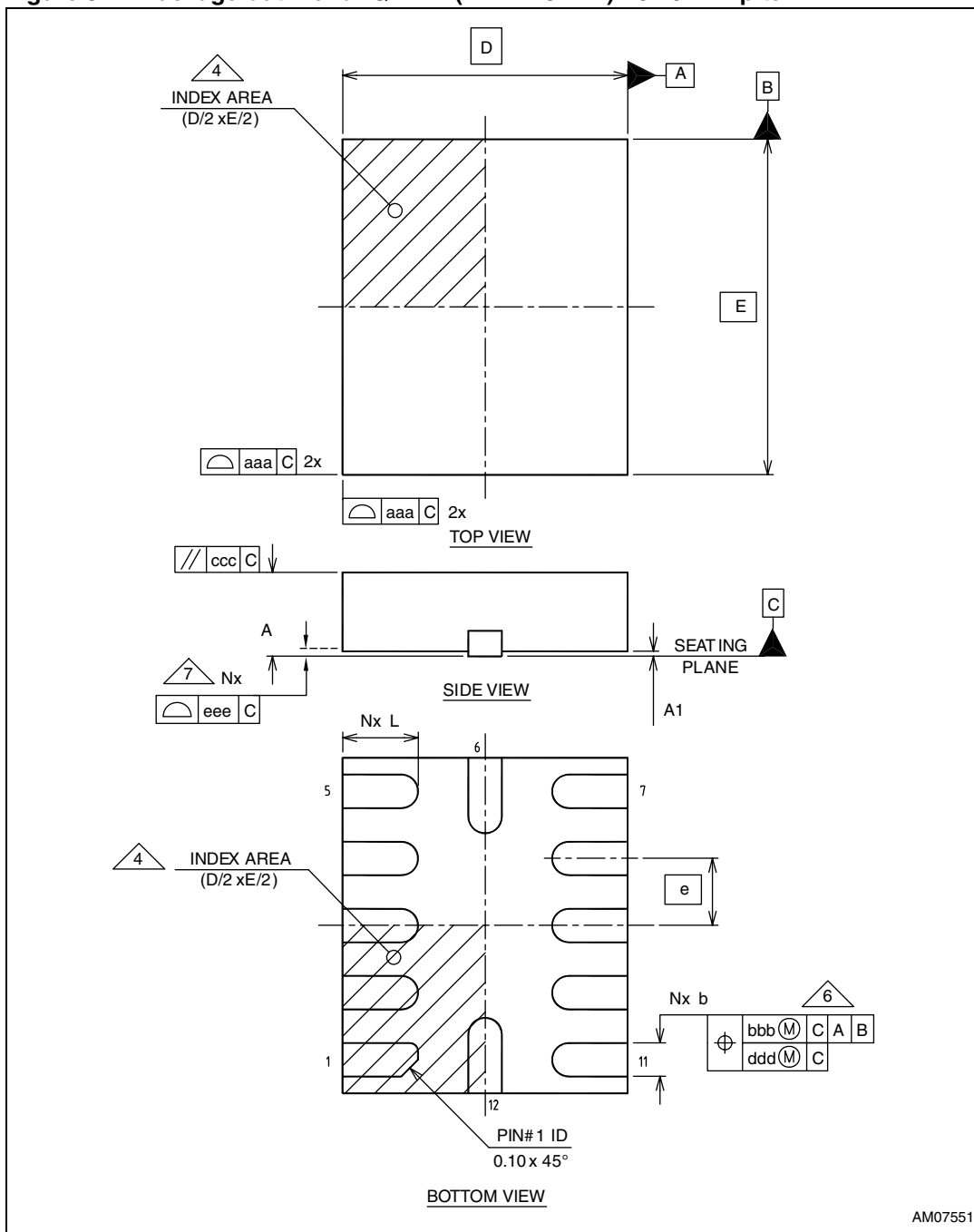
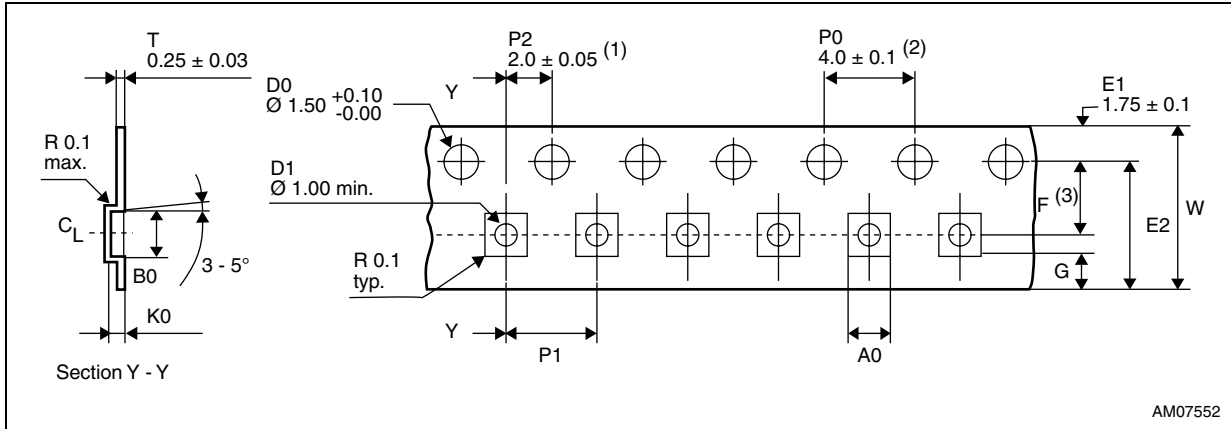


Table 12. Mechanical data for QFN12 (1.7 x 2.0 mm) - 0.40 mm pitch

| Symbol | Dimensions | | |
|--------------------|------------|------|------|
| | mm. | | |
| | Min. | Nom. | Max. |
| A | 0.45 | 0.50 | 0.55 |
| A1 | 0.00 | 0.02 | 0.05 |
| b | 0.15 | 0.20 | 0.25 |
| D | 1.70 BSC | | |
| E | 2.00 BSC | | |
| e | 0.40 BSC | | |
| L | 0.35 | 0.45 | 0.55 |
| aaa | 0.05 | | |
| bbb | 0.07 | | |
| ccc | 0.10 | | |
| ddd | 0.05 | | |
| eee | 0.08 | | |
| N | 12 | | |
| ND | 1 | | |
| NE | 5 | | |
| Notes | (1), (2) | | |
| LF part No. | - | | |
| LF DWG. No. | B-2888 | | |

1. Dimensioning and tolerance conform to ASME Y14.5M-1994.
2. All dimensions are in millimeters.
3. N is the total number of terminals.
4. The location of the terminal #1 identifier and terminal numbering convention conforms to JEDEC publication 95 SPP-002.
5. ND and NE refer to the number of terminals on the D and E side respectively.
6. Dimension b applies to the metallized terminal. If the terminal has the optional radius on the other end of the terminal, dimension b should not be measured in that radius area.
7. Coplanarity applies to the terminals and all other bottom surface metallization.
8. NJ in the variation code refers to a package which is not currently JEDEC registered.

Figure 9. Carrier tape for QFN12 (1.7 x 2.0 mm) - 0.40 mm pitch



1. Measured from centerline of sprocket hole to centerline of pocket.
2. Cumulative tolerance of sprocket holes is ± 0.20 .
3. Measured from centerline of sprocket hole to centerline of pocket.
4. Other material available.
5. All dimensions are in millimeters unless otherwise stated.

Table 13. Carrier tape dimensions

| Symbol | Dimensions |
|--------|-------------------|
| A0 | 1.80 ± 0.05 |
| B0 | 2.25 ± 0.05 |
| K0 | 0.60 ± 0.05 |
| F | 3.50 ± 0.05 |
| P1 | 4.00 ± 0.1 |
| D1 | 1.00 min. |
| T | 0.25 ± 0.03 |
| G | 0.75 min. |
| E2 | 6.25 min. |
| W | 8.00 + 0.3 / -0.1 |

Figure 10. Reel information for QFN12 (1.7 x 2.0 mm) - 0.40 mm pitch

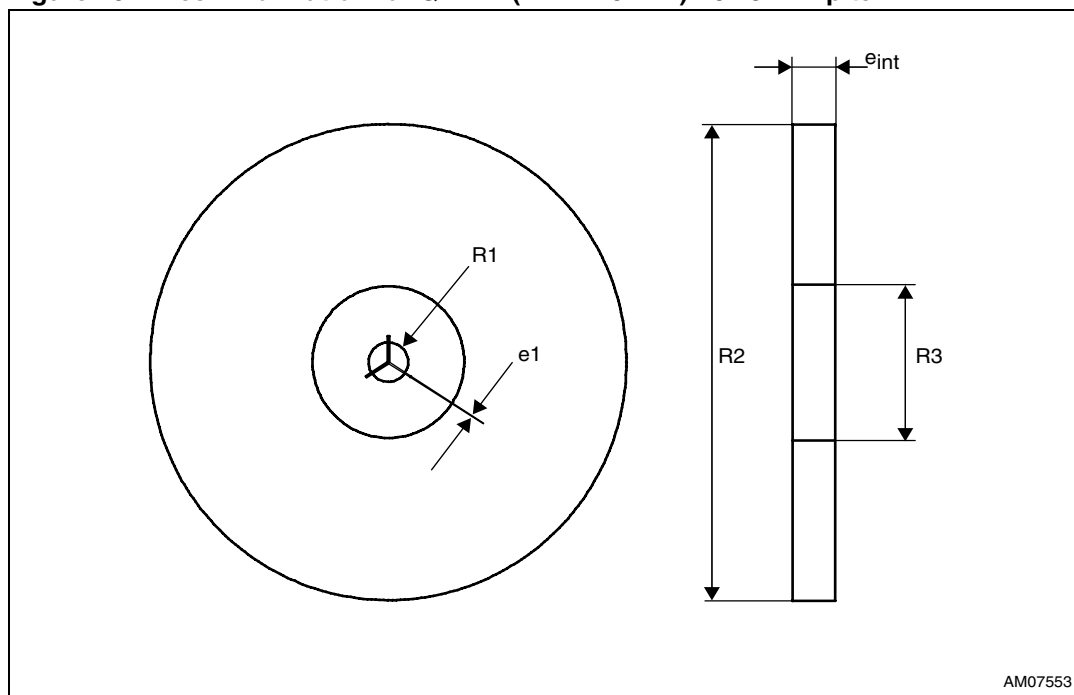


Table 14. Reel dimensions

| mm | R1 | R2 | R3 |
|---------|----|-----|----|
| Reel 7" | 13 | 180 | 60 |

9 Revision history

Table 15. Document revision history

| Date | Revision | Changes |
|-------------|----------|------------------|
| 19-Jun-2012 | 1 | Initial release. |

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